



- ★ 100% EAS Guaranteed
- ★ Green Device Available
- ★ Super Low Gate Charge
- ★ Excellent CdV/dt effect decline
- ★ Advanced high cell density Trench technology

Product Summary

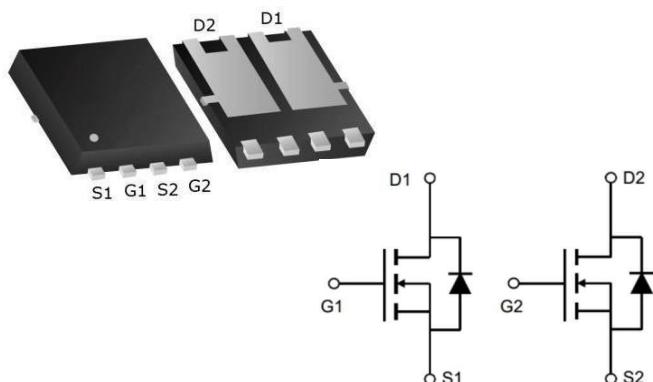
| BVDSS | RDS(on) | ID |
|-------|---------|-----|
| 30V | 5.0 mΩ | 40A |

Description

The XXW306D is the high cell density trenched N-ch MOSFETs, which provide excellent RDS(on) and gate charge for most of the synchronous buck converter applications.

The XXW306D meet the RoHS and Green Product requirement 100% EAS guaranteed with full function reliability approved.

PDFN3333-8L Pin Configuration



Absolute Maximum Ratings

| Symbol | Parameter | Rating | Units |
|---------------------------------------|--------------------------------------------------------------|------------|-------|
| V _{DS} | Drain-Source Voltage | 30 | V |
| V _{GS} | Gate-Source Voltage | ±20 | V |
| I _D @T _C =25°C | Continuous Drain Current, V _{GS} @ 10V ¹ | 40 | A |
| I _D @T _C =100°C | Continuous Drain Current, V _{GS} @ 10V ¹ | 28 | A |
| I _D @T _A =25°C | Continuous Drain Current, V _{GS} @ 10V ¹ | 17 | A |
| I _D @T _A =70°C | Continuous Drain Current, V _{GS} @ 10V ¹ | 14 | A |
| I _{DM} | Pulsed Drain Current ² | 135 | A |
| EAS | Single Pulse Avalanche Energy ³ | 39.8 | mJ |
| I _{AS} | Avalanche Current | 27 | A |
| P _D @T _C =25°C | Total Power Dissipation ⁴ | 30 | W |
| T _{STG} | Storage Temperature Range | -55 to 150 | °C |
| T _J | Operating Junction Temperature Range | -55 to 150 | °C |

Thermal Data

| Symbol | Parameter | Typ. | Max. | Unit |
|------------------|--------------------------------------------------|------|------|------|
| R _{θJA} | Thermal Resistance Junction-Ambient ¹ | --- | 50 | °C/W |
| R _{θJC} | Thermal Resistance Junction-Case ¹ | --- | 4.6 | °C/W |

Electrical Characteristics ($T_J=25^\circ C$, unless otherwise noted)

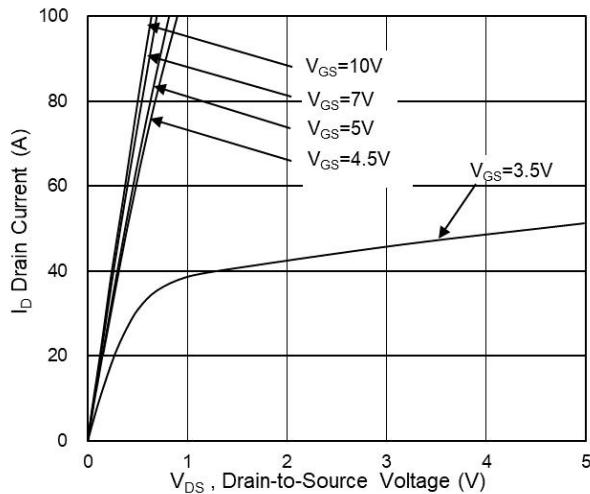
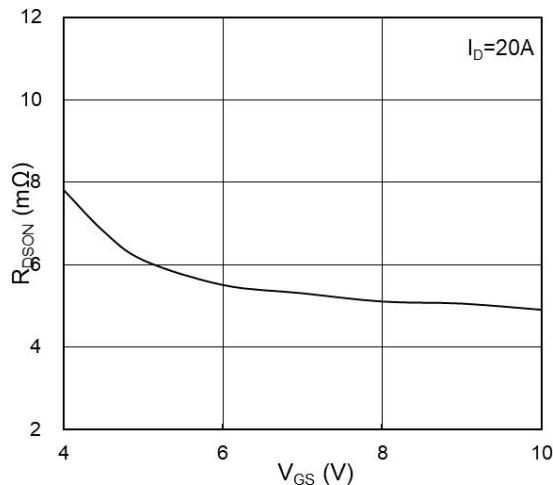
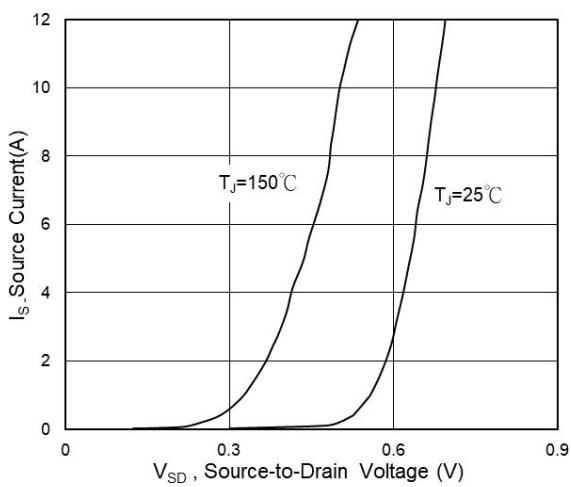
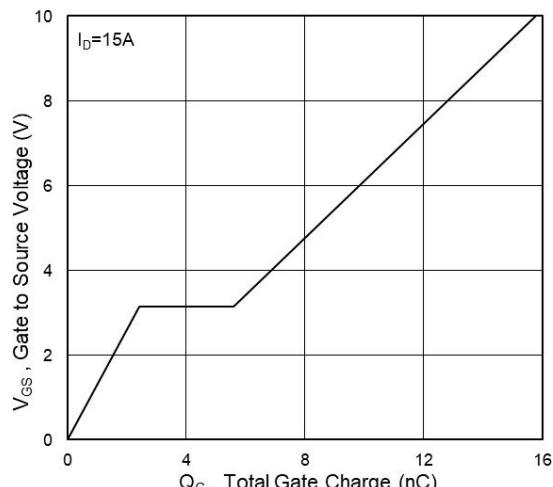
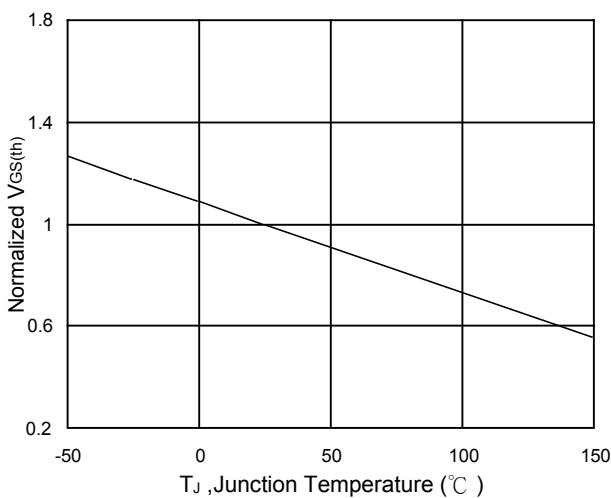
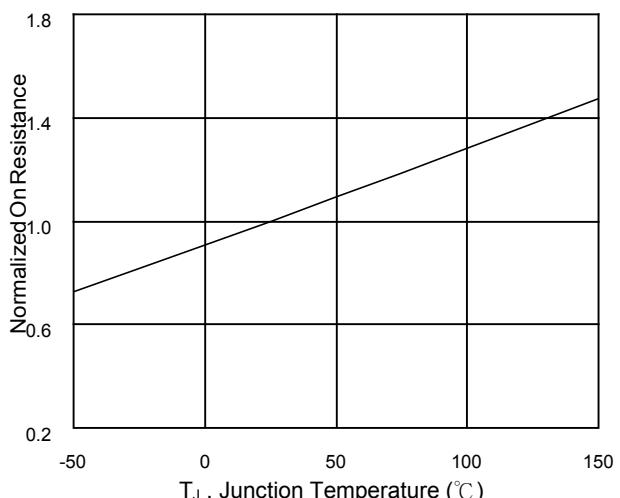
| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|--------------|------------------------------------------------|-----------------------------------------|------|------|-----------|-----------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS}=0V, I_D=250\mu A$ | 30 | --- | --- | V |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance ² | $V_{GS}=10V, I_D=20A$ | --- | 5 | 6.3 | $m\Omega$ |
| | | $V_{GS}=4.5V, I_D=15A$ | --- | 6.9 | 9 | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS}=V_{DS}, I_D=250\mu A$ | 1.2 | --- | 2.5 | V |
| $I_{DS(on)}$ | Drain-Source Leakage Current | $V_{DS}=24V, V_{GS}=0V, T_J=25^\circ C$ | --- | --- | 1 | μA |
| | | $V_{DS}=24V, V_{GS}=0V, T_J=55^\circ C$ | --- | --- | 5 | |
| I_{GSS} | Gate-Source Leakage Current | $V_{GS}=\pm 20V, V_{DS}=0V$ | --- | --- | ± 100 | nA |
| g_{fs} | Forward Transconductance | $V_{DS}=5V, I_D=20A$ | --- | 67 | --- | S |
| R_g | Gate Resistance | $V_{DS}=0V, V_{GS}=0V, f=1MHz$ | --- | 1.7 | --- | Ω |
| Q_g | Total Gate Charge (4.5V) | $V_{DS}=15V, V_{GS}=4.5V, I_D=15A$ | --- | 8 | --- | nC |
| Q_{gs} | Gate-Source Charge | | --- | 2.4 | --- | |
| Q_{gd} | Gate-Drain Charge | | --- | 3.2 | --- | |
| $T_{d(on)}$ | Turn-On Delay Time | $V_{DD}=15V, V_{GS}=10V, R_G=3.3\Omega$ | --- | 7.1 | --- | ns |
| T_r | Rise Time | | --- | 40 | --- | |
| $T_{d(off)}$ | Turn-Off Delay Time | | --- | 15 | --- | |
| T_f | Fall Time | | --- | 6 | --- | |
| C_{iss} | Input Capacitance | $V_{DS}=15V, V_{GS}=0V, f=1MHz$ | --- | 814 | --- | pF |
| C_{oss} | Output Capacitance | | --- | 208 | --- | |
| C_{rss} | Reverse Transfer Capacitance | | --- | 201 | --- | |

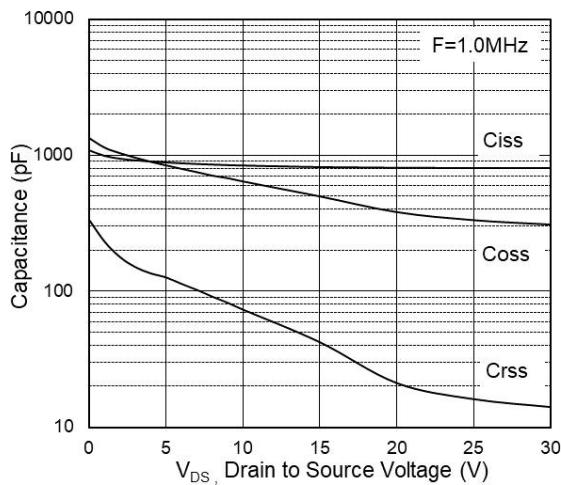
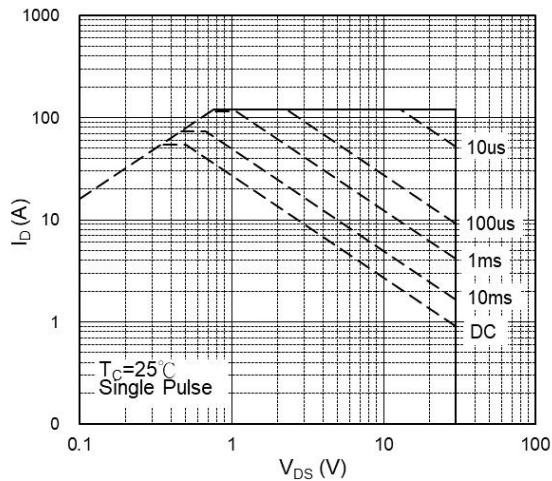
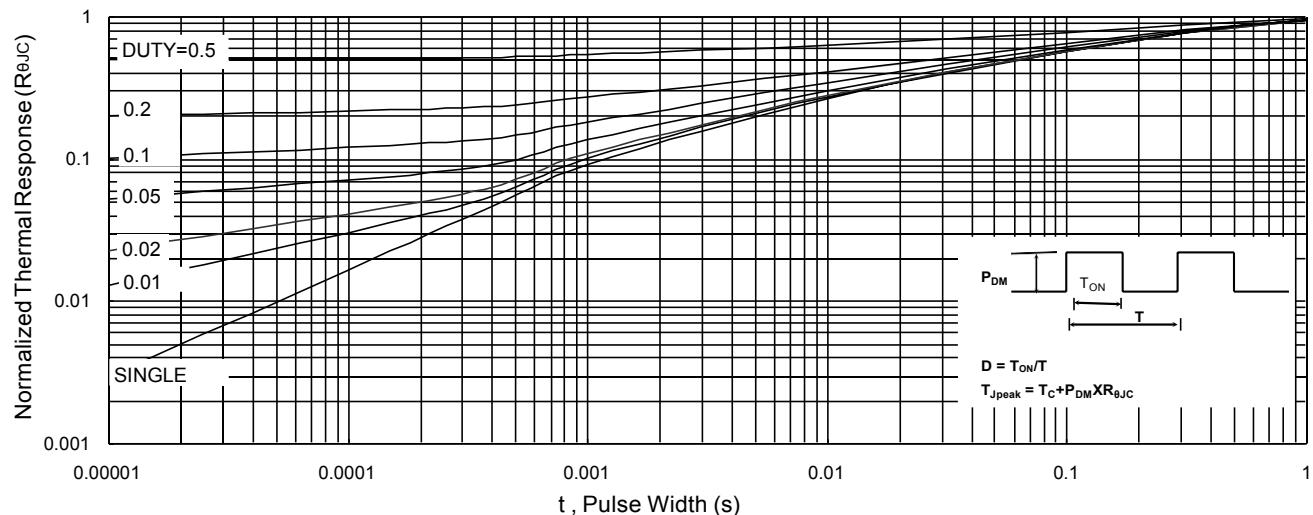
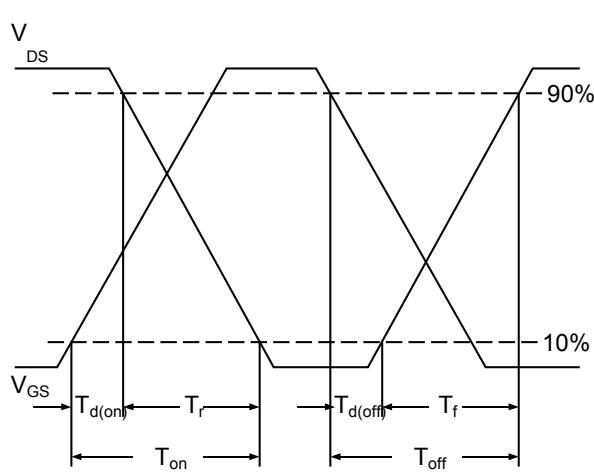
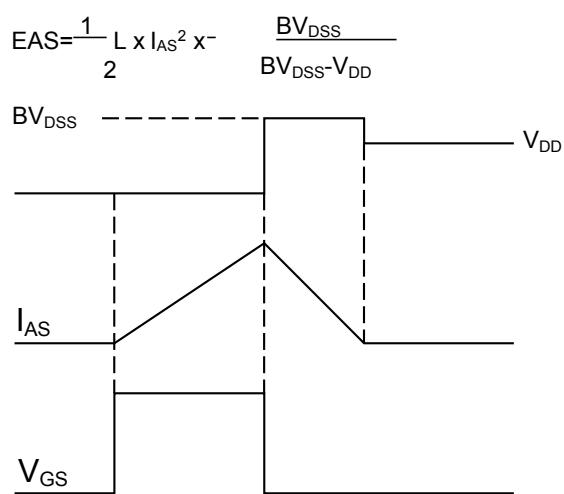
Diode Characteristics

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|----------|------------------------------------------|---------------------------------------------|------|------|------|------|
| I_s | Continuous Source Current ^{1,6} | $V_G=V_D=0V$, Force Current | --- | --- | 40 | A |
| V_{SD} | Diode Forward Voltage ² | $V_{GS}=0V, I_s=1A, T_J=25^\circ C$ | --- | --- | 1 | V |
| t_{rr} | Reverse Recovery Time | $I_F=20A, di/dt=100A/\mu s, T_J=25^\circ C$ | --- | 15 | --- | nS |
| Q_{rr} | Reverse Recovery Charge | | --- | 25 | --- | nC |

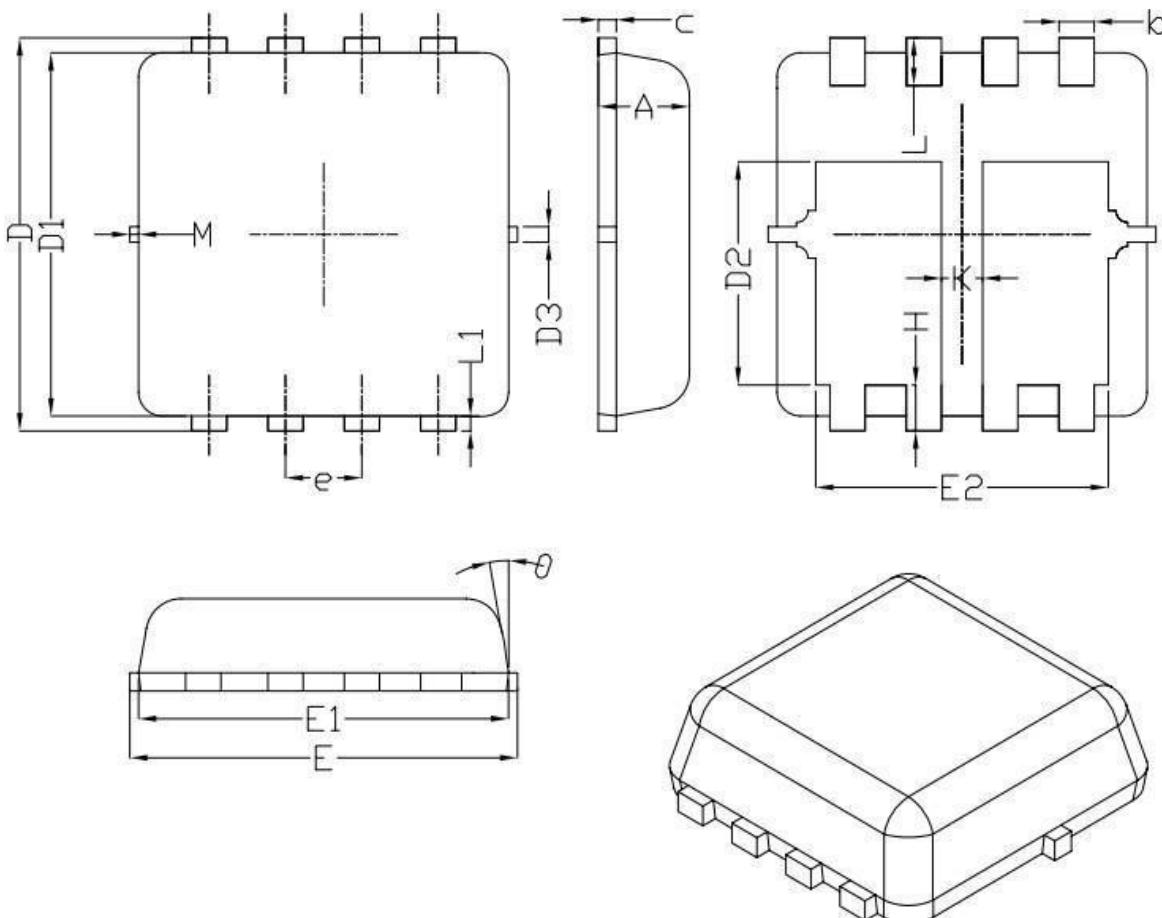
Note :

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is $V_{DD}=25V, V_{GS}=10V, L=0.1mH, I_{AS}=24A$
- 4.The power dissipation is limited by $150^\circ C$ junction temperature
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics

Fig.1 Typical Output Characteristics

Fig.2 On-Resistance vs G-S Voltage

Fig.3 Source Drain Forward Characteristics

Fig.4 Gate-Charge Characteristics

Fig.5 Normalized $V_{GS(th)}$ vs T_J

Fig.6 Normalized $R_{DS(on)}$ vs T_J

Dual N-Ch 30V Fast Switching MOSFETs

Fig.7 Capacitance

Fig.8 Safe Operating Area

Fig.9 Normalized Maximum Transient Thermal Impedance

Fig.10 Switching Time Waveform

Fig.11 Unclamped Inductive Switching Waveform

Dual PDFN3333-8L Package Outline Data



| Symbol | Dimensions (unit: mm) | | |
|-----------------|-----------------------|------|------|
| | Min | Typ | Max |
| A | 0.70 | 0.75 | 0.80 |
| b | 0.25 | 0.30 | 0.35 |
| c | 0.10 | 0.15 | 0.25 |
| D | 3.25 | 3.35 | 3.45 |
| D1 | 3.00 | 3.10 | 3.20 |
| D2 | 1.78 | 1.88 | 1.98 |
| D3 | -- | 0.13 | -- |
| E | 3.20 | 3.30 | 3.40 |
| E1 | 3.00 | 3.15 | 3.20 |
| E2 | 2.39 | 2.49 | 2.59 |
| e | 0.65 BSC | | |
| H | 0.30 | 0.39 | 0.50 |
| L | 0.30 | 0.40 | 0.50 |
| L1 | -- | 0.13 | -- |
| K | 0.30 | -- | -- |
| θ | -- | 10° | 12° |
| M | * | * | 0.15 |
| * Not Specified | | | |

Notes:

- Refer to JEDEC MO-240 variation CA.
- Dimensions "D1" and "E1" do NOT include mold flash protrusions or gate burrs.
- Dimensions "D1" and "E1" include interterminal flash or protrusion.